

<b>Notice of References Cited</b>	Application/Control No. 10/596,920		Applicant(s)/Patent Under Reexamination VAN BOMMEL ET AL.	
	Examiner Leah Schlientz		Art Unit 1618	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,500,953	03-2009	Oraevsky et al.	600/458
*	C	US-2002/0103517	08-2002	West et al.	607/88
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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